
N-Channel 30-V (D-S) Rated MOSFET + Schottky Diode

Characteristics

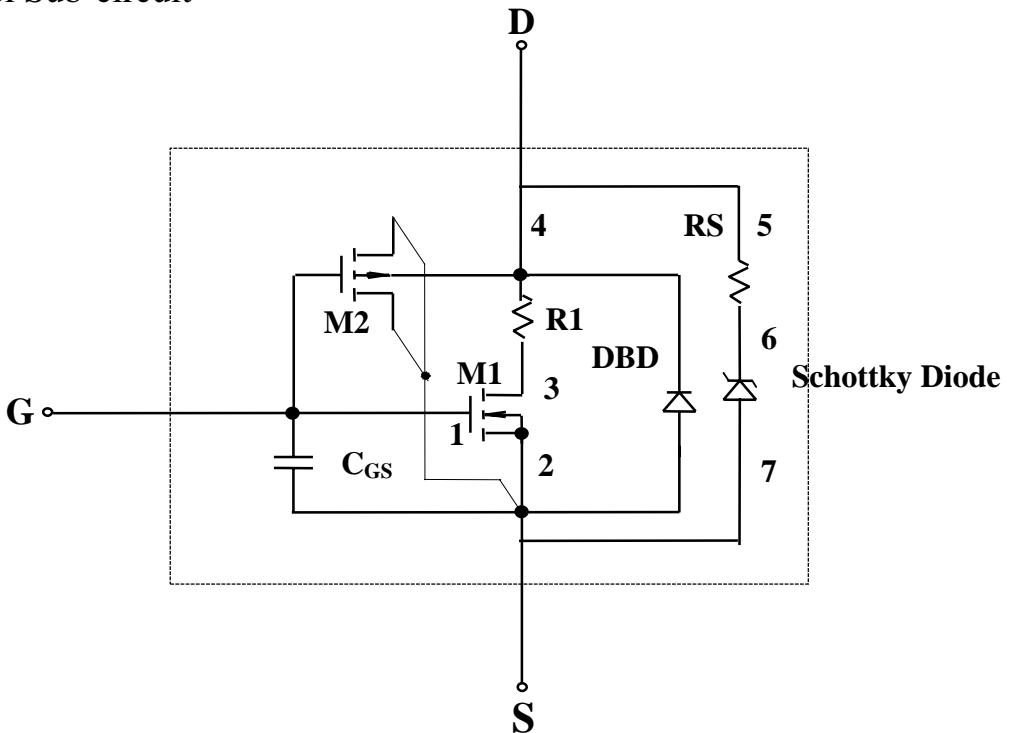
- N-channel Vertical DMOS
- Macro-Model (Sub-circuit)
- Level 3 MOS
- Applicable for Both Linear and Switch Mode
- Applicable Over a -55 to 125°C Temperature Range
- Models Gate Charge, Transient, and Diode Reverse Recovery Characteristics

Description

The attached SPICE Model describes typical electrical characteristics of the n-channel vertical DMOS. The sub-circuit model was extracted and optimized over a 25°C to 125°C temperature range under pulse conditions for 0 to 10 volt gate drives. Saturated output impedance model accuracy has been maximized for gate biases near threshold. A novel gate-to-drain feedback

capacitance network is used to model gate charge characteristics while avoiding convergence problems of switched C_{gd} model. Model parameter values are optimized to provide a best fit to measure electrical data and are not intended as an exact physical description of a device.

Model Sub-circuit



This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.



SPICE Device Model Si4810DY

Model Evaluation

N-Channel Device ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Parameter	Symbol	Test Conditions	Typ	Unit
Static				
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.94	V
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \geq 5\text{V}, V_{GS} = 10\text{V}$	444	A
Drain-Source On-State Resistance ^a	$r_{DS(\text{on})}$	$V_{GS} = 10\text{V}, I_D = 10\text{A}$ $V_{GS} = 4.5\text{V}, I_D = 5\text{A}$	0.0096 0.0168	Ω
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15\text{V}, I_D = 10\text{A}$	25	S
Schottky Diode Forward Voltage ^a	V_{SD}	$I_S = 3\text{A}, V_{GS} = 0\text{V}$ $I_S = 3\text{A}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$	0.47 0.38	V
Dynamic				
Total Gate Charge	Q_g	$V_{DS} = 15\text{V}, V_{GS} = 10\text{V}, I_D = 10\text{A}$	37	nC
Gate-Source Charge	Q_{gs}		8	
Gate-Drain Charge	Q_{gd}		7	
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = 15\text{V}, R_L = 15\Omega$ $I_D \approx 1\text{A}, V_{GEN} = 10\text{V}, R_G = 6\Omega$	15	ns
Rise Time	t_r		8	
Turn-Off Delay Time	$t_{d(\text{off})}$		39	
Fall Time	t_f		37	
Reverse Recovery Time	t_{rr}	$I_F = 3\text{A}, di/dt = 100\text{A}/\mu\text{s}$	40	

Notes:

- a) Pulse test: Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.
- b) Guaranteed by design, not subject to production testing.

Comparison of Model with Measured Data
($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

